

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination BEAUCHEANT ET AL.	
		Examiner WAYNE CAI	Art Unit 2617	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0133565	07-2003	Chang et al.	379/406.01
*	B	US-2002/0016161	02-2002	Dellien et al.	455/403
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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